

Search Notes

Application/Control No.

10/674,317

Examiner

Ivan H. Carpio

Applicant(s)/Patent under
Reexamination

LIN ET AL.

Art Unit

SEARCHED

Class	Subclass	Date	Examiner
361	799	9/13/2005	IC
174	260	9/13/2005	IC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Key word searched 361/782-784,792-798,174/260,261 with ground plane and ground pad	9/13/2005	IC
Text searched semiconductor, solder ball, ground plane, pad, non-solder mask defined	9/13/2005	IC
Discussed search field and good key words with Tuan Dihn	9/13/2005	ic